Applicant(s)/Patent Under Application/Control No. Reexamination 10/059,291 SCHMIDT ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 L. G. Lauchman 2877 **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Classification Name MM-YYYY US-6,231,190 05-2001 Dewald, D. Scott 353/31 Α US-5,264,905 11-1993 356/6 Cavanagh et al. US-3,572,944 03-1971 Hanline et al. 356/406 С US-D US-US-F US-G Н US-US-US-Κ US-US-US-

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